

<b>Notice of References Cited</b>	Application/Control No. 10/829,535		Applicant(s)/Patent Under Reexamination VERBOWSKI, LARRY J.	
	Examiner Leonard J. McCreary, Jr.		Art Unit 3616	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0046138	03-2005	Dagg et al.	280/124.166
*	B	US-4,033,605	07-1977	Smith et al.	280/6.157
*	C	US-5,163,701	11-1992	Cromley, Jr., John D.	280/124.13
*	D	US-5,332,255	07-1994	Velazquez, Alfonso	280/86.754
*	E	US-5,609,331	03-1997	Hoag et al.	267/154
*	F	US-5,685,527	11-1997	Harbali et al.	267/277
*	G	US-5,921,569	07-1999	Noutomi et al.	280/124.167
*	H	US-6,398,451	06-2002	Zetterstrom, Sigvard	403/347
*	I	US-6,447,073	09-2002	Goettker, Bernhardt P.	301/127
*	J	US-6,767,021	07-2004	Schnurpel, Jeremiah L.	280/124.13
*	K	US-6,779,806	08-2004	Breitbach et al.	280/124.106
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.